Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/717,700	NAKAMURA, TAKAHIRO
Examiner	Art Unit
Ha T. Nguyen	2812

	SEARCHED					
Class	Subclass	Date	Examiner			
29	25.03	4/19/2005	HN			
361	523,525	4/19/2005	HN			
427	79,80	4/19/2005	HN			
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INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
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